

Search Notes

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Examiner

Patrick D. Nguyen

Applicant(s)/Patent under
Reexamination

SWAIN ET AL.

Art Unit

3629

SEARCHED

Class	Subclass	Date	Examiner
714	4	9/21/2005	NN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See Attached Search History	9/21/2005	NN